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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/717,257	11/18/2003	Phuc Van	7701		
7	590 12/30/2004		EXAM	INER	
Ann Koo	ort Charact	TANG, MINH NHUT			
1631 North Fir San Jose, CA			ART UNIT	PAPER NUMBER	
			2829		
			DATE MAILED: 12/30/2004		

Please find below and/or attached an Office communication concerning this application or proceeding.

	Applica	tion No.	Applicant(s)			
		257	VAN ET AL.			
Office Action Summary	Examin	er	Art Unit .			
	Minh N.	Tang	2829			
The MAILING DATE of this comm Period for Reply	unication appears on t	he cover sheet with the c	orrespondence address			
A SHORTENED STATUTORY PERIOD THE MAILING DATE OF THIS COMMU. - Extensions of time may be available under the provisi after SIX (6) MONTHS from the mailing date of this co. If the period for reply specified above is less than thirt. - If NO period for reply is specified above, the maximum. - Failure to reply within the set or extended period for reany reply received by the Office later than three mont earned patent term adjustment. See 37 CFR 1.704(b)	NICATION. ons of 37 CFR 1.136(a). In no emmunication. (30) days, a reply within the so a statutory period will apply and ply will, by statute, cause the ans after the mailing date of this	event, however, may a reply be tim tatutory minimum of thirty (30) days will expire SIX (6) MONTHS from pplication to become ABANDONE	ely filed swill be considered timely. the mailing date of this communicatio D (35 U.S.C. § 133).	ın.		
Status						
2a) ☐ This action is FINAL. 3) ☐ Since this application is in condition						
Disposition of Claims						
4) ☐ Claim(s) 1-17 is/are pending in the application. 4a) Of the above claim(s) is/are withdrawn from consideration. 5) ☐ Claim(s) is/are allowed. 6) ☐ Claim(s) is/are rejected. 7) ☐ Claim(s) 1-17 is/are objected to. 8) ☐ Claim(s) are subject to restriction and/or election requirement.						
Application Papers						
9) The specification is objected to by 10) The drawing(s) filed on 18 Novem Applicant may not request that any of Replacement drawing sheet(s) included 11) The oath or declaration is objected.	<u>ber 2003</u> is/are: a)☐ bjection to the drawing(s ing the correction is requ) be held in abeyance. Sec uired if the drawing(s) is ob	e 37 CFR 1.85(a). ected to. See 37 CFR 1.121((d) .		
Priority under 35 U.S.C. § 119						
 12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some * c) None of: 1. Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No. 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received. 						
Attachment(s)		0 🗆 1-1-1-1-1	(DTO 442)			
 Notice of References Cited (PTO-892) Notice of Draftsperson's Patent Drawing Review Information Disclosure Statement(s) (PTO-1448 Paper No(s)/Mail Date 		4) Interview Summary Paper No(s)/Mail D: 5) Notice of Informal F 6) Other:				

Application/Control Number: 10/717,257 Page 2

Art Unit: 2829

DETAILED ACTION

Drawings

- 1. The drawings are objected to as failing to comply with 37 CFR 1.84(p)(5) because they include the following reference character(s) not mentioned in the description: reference numbers 3, 4, and 5 in Figs. 1, 1A and 1B. Corrected drawing sheets in compliance with 37 CFR 1.121(d), or amendment to the specification to add the reference character(s) in the description in compliance with 37 CFR 1.121(b) are required in reply to the Office action to avoid abandonment of the application. Any amended replacement drawing sheet should include all of the figures appearing on the immediate prior version of the sheet, even if only one figure is being amended. The replacement sheet(s) should be labeled "Replacement Sheet" in the page header (as per 37 CFR 1.84(c)) so as not to obstruct any portion of the drawing figures. If the changes are not accepted by the examiner, the applicant will be notified and informed of any required corrective action in the next Office action. The objection to the drawings will not be held in abeyance.
- 2. The drawings are objected to as failing to comply with 37 CFR 1.84(p)(4) because reference character "15" in Fig. 1B has been used to designate both CCD camera and a connection between lock-in amp. 13 and SPV probe 11. Corrected drawing sheets in compliance with 37 CFR 1.121(d) are required in reply to the Office action to avoid abandonment of the application. Any amended replacement drawing sheet should include all of the figures appearing on the immediate prior version of the sheet, even if only one figure is being amended. The replacement sheet(s) should be

Application/Control Number: 10/717,257 Page 3

Art Unit: 2829

labeled "Replacement Sheet" in the page header (as per 37 CFR 1.84(c)) so as not to obstruct any portion of the drawing figures. If the changes are not accepted by the examiner, the applicant will be notified and informed of any required corrective action in the next Office action. The objection to the drawings will not be held in abeyance.

Specification

3. The disclosure is objected to because of the following informalities:

a/ on page 3, line 3, "5.025,145" should be -- 5,025,145 --.

b/ on page 6, line 22, "1a" should be -- 1A --.

c/ on page 7, line 4, "1b" should be -- 1B --.

d/ on page 8, "trough" (line 11), and "look-in" (line 17) should be -- through --, and -- lock-in --, respectively.

e/ on page 9, line 8, "Fig.3, 4" should be -- Figs. 3 and 4 --.

f/ on page 10, "optical fiber 17" (line 16), and "look-in" (line 17) should be -- optical fiber 7 --, and -- lock-in --, respectively.

g/ on page 11, line 13, "look-in" should be -- lock-in --.

Appropriate correction is required.

4. Applicant's cooperation is requested in correcting any errors of which applicant may become aware in the specification.

Claim Objections

5. Claims 1-17 are objected to because of the following informalities:

a/ in claim 1, "a transparent element placed on surface of the transparent element" (lines 5-6), "a said transparent element" (line 7), "computer" (line 11), "photo"

Art Unit: 2829

detector" (line 13), "said measuring system" (line 15), "to said pre-amplifier input, said pre-amplifier output connected to said lock-in amplifier input and said lock-amplifier output connected to computer" (lines 16-18), "pre-amplifier input and said pre-amplifier output connected to computer" (lines 20-21), "to computer" (line 25), "probe electrode" (lines 26-27), and "said stages controlled by computer" (lines 29-30) should be -- a transparent element placed on surface of the electrode --, -- said transparent element --, -- a computer --, -- a photo detector --, -- said means for measuring --, -- to the input of said SPV pre-amplifier, the output of said SPV pre-amplifier connected to the input of said lock-in amplifier and the output of said lock-in amplifier connected to said computer --, -- the input of said pre-amplifier and the output of said pre-amplifier connected to said computer --, -- to said computer --, -- electrode --, and -- said linear stages and said rotary stage controlled by said computer --, respectively.

c/ in claim 2, "the transparent element of the probe electrode" (lines 1-2), "the transparent glass" (line 2), "said transparent being disk" (lines 3-4), "the metal ring" (line 4), and "the central region" (line 5) should be -- the transparent element --, -- a

b/ in claims 2-11, all in line 1, "An apparatus" should be -- The apparatus --.

transparent glass --, -- said transparent disk being --, -- a metal ring --, and -- a central region --, respectively.

d/ in claim 4, line 2, "the optical combiners" should be -- an optical combiners --.
e/ in claim 5, "a transparent substrate" (line 2), and "the optical collimator" (line 3)
should be -- said electrode --, and -- an optical collimator --, respectively.

Art Unit: 2829

f/ in claim 6, "radiation" (line 3), "said probe" (line 5), "an electrode" (lines 5-6), "transparent element" (line 6), "a non-transparent element" (lines 6-7), "said transparent" (line 7), "said radiation" (lines 7-8), "said non-transparent" (line 8), "said transparent element" (lines 8-9), "said electrode" (line 9), "computer" (line 13), "said transparent element" (line 14), "said electrode of the probe and photo detector" (line 15), "said electrode" (line 17), "a pre-amplifier" (line 17), "a lock-in amplifier" (line 17), "said electrode connected to said pre-amplifier input, said pre-amplifier output connected to said lock-in amplifier input and said lock-amplifier output connected to a computer" (lines 18-20), and "pre-amplifier with said photo detector connected to pre-amplifier input and said pre-amplifier output connected to computer" (lines 21-23) should be -- a second radiation --, -- said second probe --, -- a second electrode --, -- a second transparent element --, -- a second non-transparent element --, -- said second transparent --, -- said second radiation --, -- said second non-transparent --, -- said second transparent element --, -- said second electrode --, -- said computer --, -- said second transparent element --, -- said second electrode of the second probe and a second photo detector --, -- said second electrode --, -- a second pre-amplifier --, -- a second lock-in amplifier --, -- said second electrode connected to the input of said second pre-amplifier, the output of said second pre-amplifier connected to the input of said second lock-in amplifier and the output of said second lock-in amplifier connected to said computer --, and -- a third pre-amplifier with said second photo detector connected to the input of said third pre-amplifier and the output of said third preamplifier connected to said computer --, respectively.

Art Unit: 2829

g/ in claim 7, "the transparent element" (line 1), "the probe" (line 1), "a transparent glass" (lines 1-2), "said transparent disk" (line 2), "said transparent disk" (line 3), and "a metal ring" (line 4) should be -- the second transparent element --, -- the second probe --, -- a second transparent glass --, -- said second transparent disk --, -- said second transparent disk --, and -- a second metal ring --, respectively.

Page 6

h/ in claim 8, "said transparent disk" (line 1), and "outer diameter of the metal ring" (line 2) should be -- said second transparent disk --, and -- the outer diameter of the second metal ring --, respectively.

i/ in claim 9, line 2, "a wafer surface" should be -- the wafer surface --.

j/ in claim 10, "a second transparent element" (line 2), "the probe" (line 2), "said SPV probe" (line 4), "said probe electrode" (line 5), and "said photo detector" (line 6) should be -- said second transparent element --, -- the second probe --, -- said second probe --, -- said second electrode --, and -- said second photo detector --, respectively.

k/ in claim 12, "the wafer" (line 1), "the illumination area" (line 4), "back side" (line 4), and "back side" (line 6) should be -- a wafer --, -- an illumination area --, -- a back side --, and -- the back side --, respectively.

I/ in claims 13-17, all in line 1, "A method" should be -- The method --.

Appropriate correction is required.

Conclusion

6. This application is in condition for allowance except for the following formal matters: the objections to the drawings, the specification and the claims as set forth above.

Application/Control Number: 10/717,257

Art Unit: 2829

Prosecution on the merits is closed in accordance with the practice under *Ex* parte Quayle, 1935 C.D. 11, 453 O.G. 213.

A shortened statutory period for reply to this action is set to expire **TWO**MONTHS from the mailing date of this letter.

7. The following is a statement of reasons for the indication of allowable subject matter:

Claims 1-11 recite, inter alia, an apparatus for determining the diffusion length of semiconductor wafers comprising means for measuring surface photovoltage (SPV) signals picked up by said electrode, said means for measuring including SPV preamplifier and lock-in amplifier with said electrode connected to the input of said SPV pre-amplifier, the output of said SPV pre-amplifier connected to the input of said lock-in amplifier and the output of said lock-in amplifier connected to said computer.

Claims 12-17 recite, inter alia, a method for determining diffusion length in predetermined regions of a wafer comprising illuminating said area on the back side wafer surface with frequency modulated light with predetermined intensities at a series of wavelengths, λ_i , measuring light fluxes Φ_i directed onto said illumination area and measuring photovoltages Vi from said illuminating area, illuminating said area at different intensities at the same wavelength λ_i , measuring light fluxes Φ_i and Φ_{il} and corresponding surface photovoltages V_i , and determining the diffusion length using values V_i , Φ_i and intercept of the plot Φ_i/V_i versus light penetration depth.

The art of record does not disclose the above limitations, nor would it be obvious to modify the art of record so as to include the above limitations.

Application/Control Number: 10/717,257 Page 8

Art Unit: 2829

8. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure:

Lagowski et al.	6,512,384	Method For Fast And Accurate Determination
		Of The Minority Carrier Diffusion Length From
		Simultaneously Measured Surface
		Photovoltages.
Lagowski et al.	5,663,657	Determining Long Minority Carrier Diffusion
		Lengths.
Lagowski	5,025,145	Method And Apparatus For Determining The
		Minority Carrier Diffusion Length From Linear
		Constant Photon Flux Photovoltage
		Measurements.
Goodman	4,333,051	Method And Apparatus For Determining
		Minority Carrier Diffusion Length In
		Semiconductors.

9. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Minh N. Tang whose telephone number is (571) 272-1971. The examiner can normally be reached on M-F (7:00-3:30).

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Nestor R. Ramirez can be reached on (571) 272-2034. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Application/Control Number: 10/717,257

Art Unit: 2829

Page 9

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

MINH NHUT TANG
PRIMARY EXAMINER

12/22/04